

Tuning the Electronic Properties of Janus GeSnS₂ Monolayers through Strain and Electric Field †

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Abstract: This study investigates the electronic properties of a single layer of the novel Janus material GeSnS₂ using density functional theory. By utilizing the hybrid functional HSE06 in addition to the standard PBE approximation, the study aims to obtain accurate findings about how changes in strain and electric field affect the material's electronic properties. The results of the study reveal that the bandgap energy of the GeSnS₂ monolayer is 2.15 eV and that it exhibits an indirect band gap behavior. The study also shows that by applying strain or an electric field, the bandgap of the material can be changed, which has significant implications for the material's potential applications. The study found that when strain is applied, the bandgap changes significantly. Furthermore, the study discovered that the electric field has a slight effect in changing the bandgap of GeSnS₂ monolayer when the electric field is changed from 0 to 8 V/nm an, and a band shift occurs under certain conditions. The study provides valuable insight into the potential of GeSnS₂ and opens the door for further research in this field..

Keywords: GeSnS₂ monolayers; strain; electric field; DFT

1. Introduction

The scientific community has shown a growing interest in two-dimensional (2D) materials due to their novel physical phenomena and potential uses in technology [1–3]. Since the discovery of graphene in 2004, numerous 2D materials with diverse electrical, optical, magnetic, and piezoelectric properties have been identified [1]. Such materials include transition metal dichalcogenides (TMDs), such as MoS₂ [4,5], and other 2D materials [6], like group IV monochalcogenides [7], that share electronic properties with black phosphorus (BP) [8,9]. These materials offer exciting opportunities for fundamental research and technological applications. Janus GeSnS₂ monolayers have emerged as a promising class of 2D materials due to their intriguing electronic and optical properties, making them attractive for applications in nanoelectronics and optoelectronics.

Recent work by Leandro Seixas [10] has demonstrated the stability of IV monochalcogenides monolayers, including GeSnS₂, through phonon dispersion calculations, highlighting their potential for applications in various fields. Additionally, researchers such as Ramesh Sivasamy [11] and Khang D. Pham [12] have explored the optical, thermodynamic, and electronic properties of different group IV monochalcogenides, further expanding our understanding of these materials and their potential uses in nanotechnology. Investigating 2D GeSnS₂ nanosheets can provide valuable insights into the atomic-scale characteristics of GeSnS₂. Although monolayered GeSnS₂ has not yet been experimentally achieved, a thorough theoretical examination of its electrical properties can deepen our understanding of its fundamental characteristics and accelerate the development of potential applications. The energy band gap is a crucial

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characteristic of any electronic material, particularly in the context of 2D electronic applications. Therefore, it is essential to understand how to regulate the electrical band structures of GeSnS2 properly.

In our research, we focus on the modulation of the electronic band structures of the GeSnS2 monolayer. Specifically, we investigate the effects of external uniform electric fields on the band gap of GeSnS2 monolayer and the changes in the electronic band structures of GeSnS2 monolayer under external strain, including both tensile and compressive strain. Our ultimate goal is to facilitate the development of GeSnS2-based 2D devices and provide a simple and practical approach to adjusting the electrical properties of GeSnS2 monolayers over a wide range.

2. Computational Details

In this study, we utilized density functional theory (DFT) to investigate the electrical band structure of Janus monolayers composed of MoSTe and WSTe. To carry out the DFT calculations, we employed the Quantum ESPRESSO package, and the projector augmented wave (PAW) method [13]. To handle the electronic exchange-correlation energy, we utilized the generalized-gradient approximation of Perdew-Burke-Ernzerhof (GGA-PBE) and hybrid functional. For the hybrid functional, we employ the Heyd-Scuseria-Ernzerhof (HSE06) functional, where the exchange and correlation potential is a mixture of the Hartree Fock method and the PBE functional [14].

The standard HSE functional (HSE06) has a fixed mixing parameter α of 0.25, but we may occasionally adjust it to match experimental outcomes. To simulate the wave function and Brillouin zone for all Janus TMDs, we employed a cut-off energy of 80 Ry and a k-point grid mesh of 18x18x1. To prevent any spurious interactions between adjacent slabs, a vacuum of 28 angstroms was established in the z-direction. The relaxed lattice parameters were determined using the Broyden-Fletcher-Goldfarb-Shanno (BFGS) optimization technique [15].

The biaxial strain applied to the GeSnS2 monolayer is defined as $\varepsilon = \frac{a-a_0}{a_0}$, where a and a_0 represent the strained and unstrained lattice constants, respectively [16]. In addition, we incorporated an external electric field E perpendicular to the 2D surface of the GeSnS2 to investigate its impact on the system.

3. Results and Discussion

For our computation, we chose the bulk GeS crystal structure with space group Pnma and lattice parameter values of $a = 4.3827 \text{ \AA}$, $b = 4.2322 \text{ \AA}$, and $c = 11.6360 \text{ \AA}$ [17] as the starting structure model. To prevent interlayer interactions, we adjusted the value of c to 28 \AA and kept a and b identical to the bulk. Figure 1 shows the top and side views of the GeSnS2 monolayer. The GeSnS2 monolayer is an orthorhombic crystal type with one Sn atom covalently bound to one Ge and two Se atoms. Unlike graphene, which has a planar 2D nanostructure, the GeSnS2 structure has a puckered honeycomb structure. The directional orientation of the monolayer affects its characteristics. After the relaxation, we present in Table 1 the obtained lattice parameters of the bulk and monolayer GeSnS2 compared with the bulk and monolayer SnS and GeS.

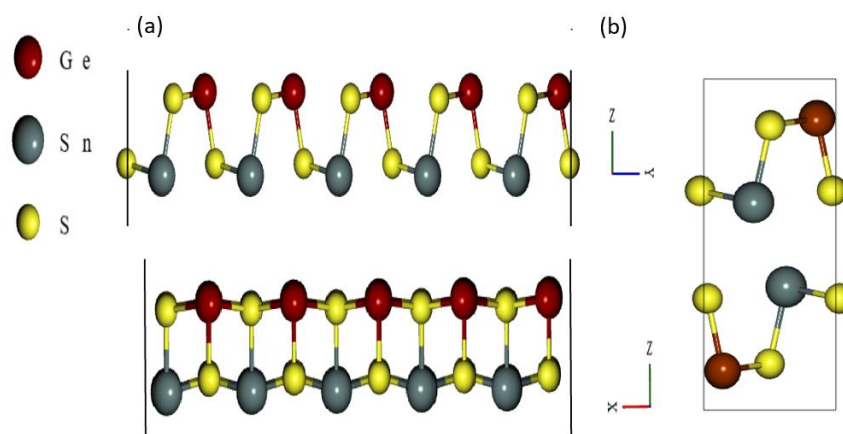


Figure 1. (a) Top and side monolayer's views, (b) the bulk structure of GeSnS2.

Table 1. This is a table. Tables should be placed in the main text near to the first time they are cited.

	a (Å)	b (Å)	c (Å)	E _g (eV)
GeSnS2	4.52	3.82		2.15 (hse)
Bulk GeSnS2	4.43	3.84	11.08	1.37 (hse)

In this study, we first compute the band structures of the GeSnS2 monolayer in its equilibrium state, as shown in Figure 2, focusing on its electrical characteristics. The results reveal that the GeSnS2 monolayer is a semiconductor at equilibrium, exhibiting a significant indirect bandgap of 2.15 eV. This finding is consistent with the outcomes of previous DFT simulations [13–16]. Additionally, we found that the bandgap of the GeSnS2 bulk is 1.37 eV lower than its monolayer counterpart. For the bulk, the conductor band minimum (CBM) is located near the Y-point, and the valence band maximum (VBM) is located at the X-point, resulting in an indirect bandgap. In contrast, for the GeSnS2 monolayer, the VBM is located at the Gamma point, and the CBM is near the X-point. The observed difference in the band structure between the bulk and monolayer of GeSnS2 is attributed to the confinement effect that also opened the band gap from 1.37 to 2.15 eV. Interestingly, the bandgap of our material is strongly influenced by the material's thickness, as reported for other 2D materials like BP [33]. Given the slight energy difference between the electronic states at the top and bottom of the valence and conduction bands, located at the X and Gamma-point, we anticipate that the band structures of the GeSnS2 monolayer can be significantly altered by the effects of either strain (b) or an external electric field (E).

The study of changes in electrical characteristics caused by external influences, such as deformation or external fields, is crucial in designing devices such as nanoelectromechanical devices or sensors. Capturing the changing laws of material characteristics resulting from these events provides us with several alternatives for applying them to specific devices.

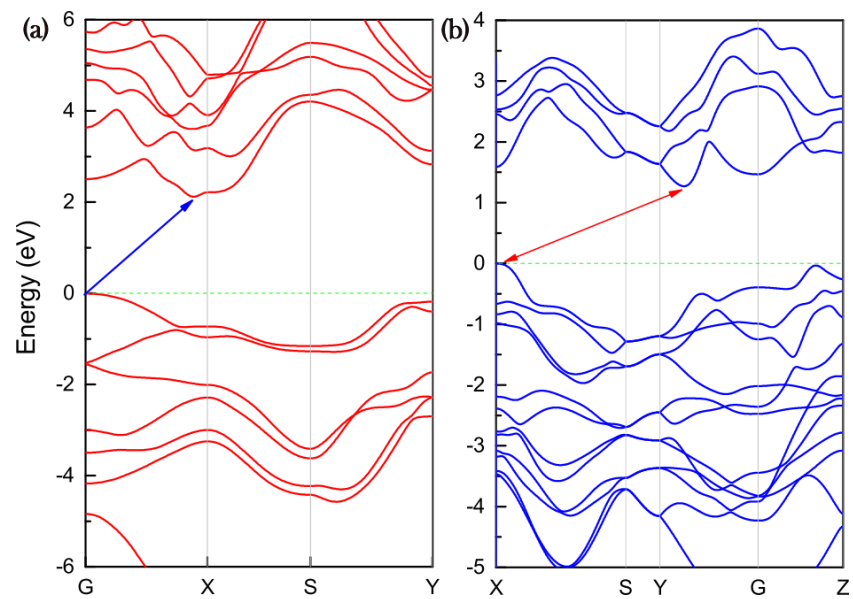


Figure 2. The band structure of (a) monolayer, (b) the bulk of GeSnS2.

To explore the impact of strain engineering on the electrical characteristics of the GeSnS2 monolayer, a biaxial strain ranging from -6% to 6% is applied to its two-dimensional surface. The “+” and “-” marks represent the tensile and compressive examples of the biaxial strain, respectively. This range of strain allows us to investigate the effects of different levels of strain on the monolayer’s electrical properties, which can inform the design of devices that rely on these characteristics. Figure 3 presents the strain-dependent band gap of Janus GeSnS2 monolayer. The band gaps show a continuous decrease under a biaxial compressive strain, while a biaxial stretched strain has the opposite effect. Specifically, as shown in Figure 6a, the bandgap changes from 2.15 eV to 1.43 eV as the strain changes from 0% to -6% . In the other hand, tensile strain has change the band gap from 2.15 to 2.44 eV.

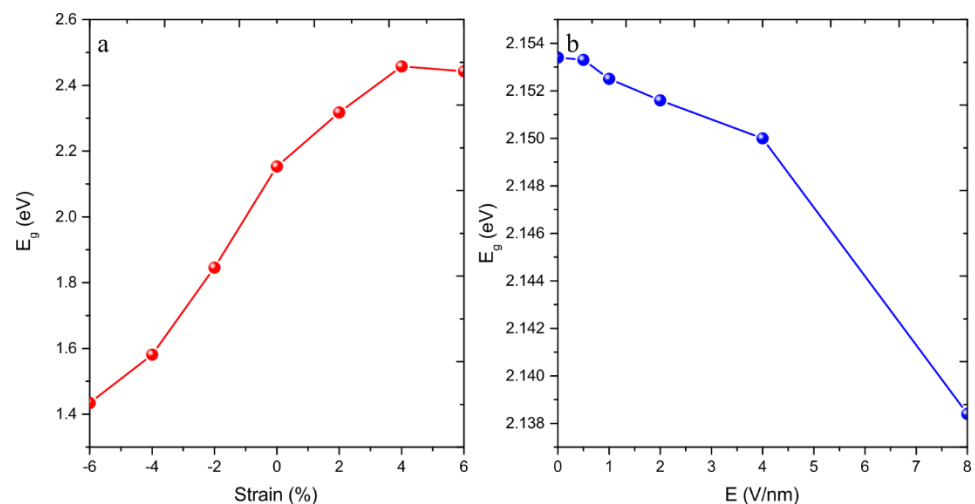


Figure 3. The variation of band gap energy with (a) strain and (b) electric field.

Interestingly, the semiconductor-metal phase transition can be induced by very high compression. GeSnS2 monolayers offer excellent opportunities for use in nanoelectromechanical devices because their electrical properties can be readily modified by strain engineering. This makes them a promising candidate for developing novel electronic and optoelectronic devices with advanced functionalities.

In this section, we investigate how the electronic properties of the GeSnS2 monolayer are affected by a perpendicular electric field labeled as E . This electric field is applied perpendicular to the GeSnS2 monolayer's 2D plane to analyze the monolayer's electronic characteristics under the influence of electricity. We apply the electric field in the z -positive axis direction and vary it from 0 V/nm to 8 V/nm (0.5, 1, 2, 4, and 8 V/nm). We present the effects of the external field E on the GeSnS2 monolayer's band gap energy in Figure 7. Our findings indicate that the band gap energy of the GeSnS2 monolayer changes slightly with a positive electric field. Our computed results reveal that the band gap energy of the GeSnS2 monolayer is 2.153 eV and 2.138 eV at $E = 0$ V/nm and $E = 8$ V/nm, respectively.

In order to get a better insight into the effect of the electric field, we present the Band structures of the GeSnS2 monolayer in Figure 6. As we can see in this figure, the conduction band is more sensitive to the electric field than the valance band. We also observe that the diminution of the band gap is attributed to the shift in the conduction band. A transition from indirect to direct band gap occurs when an electric field of 8 V/nm is applied, even though there is no major change in the band gap energy. The band gap is transformed from Gamma-X to a direct band gap at Gamma with an energy of 2.138 eV

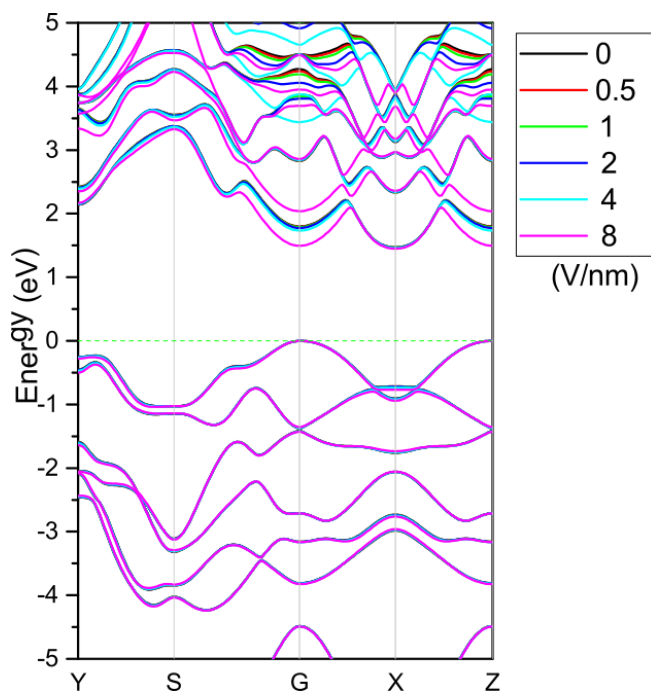


Figure 3. The effect of electric field on the band structure of monolayer GeSnS2.

The ability to manipulate electronic properties, particularly through the application of an external field, makes it even more attractive for use in these applications. One important characteristic that can be controlled is the transition from an indirect to a direct semiconductor, which significantly impacts the efficiency of electron transport and, ultimately, the device's performance. By exploiting this characteristic, GeSnS2 can potentially be used in various applications, such as developing highly efficient and compact nanoelectronic devices. The ability to precisely manipulate the electronic properties of GeSnS2 monolayer at the nanoscale level opens up new opportunities for advancing nanoelectronics and designing novel devices with unprecedented performance.

4. Conclusion

In our research, we investigated the modulation of the electronic band structures of the GeSnS2 monolayer through external electric fields and strain. Our findings reveal that

external electric fields can effectively tune the band gap of the GeSnS₂ monolayer, providing a promising avenue for designing high-performance electronic devices. Additionally, we demonstrated that both tensile and compressive strain could alter the electronic band structures of the GeSnS₂ monolayer, allowing for further control over its electronic properties. Furthermore, we observed that electric fields could slightly change the band gap of semiconductors, with the possibility of an indirect-direct bandgap transition occurring at specific electric field intensities. By carefully controlling these factors, we can unlock the full potential of semiconductors and pave the way for a wide range of innovative and high-performance electronic devices.

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